


<b>Search Notes</b>  	<b>Application/Control No.</b>  10538202	<b>Applicant(s)/Patent Under Reexamination</b>  CHANG, CHIN
	<b>Examiner</b>  Inventor Abdi, Amara	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	162	01/12/2009	Amara Abdi
345	83	01/12/2009	Amara Abdi
348	272	01/12/2009	Amara Abdi

SEARCH NOTES		
Search Notes	Date	Examiner
East: USPAT, US-PGPUB, EPO, JP, DERWENT	01/12/2009	Amara Abdi
Google, E-Journal, IEEE explorer, STIC	01/12/2009	Amara Abdi
Consulted with the SPE Jingge Wu and Samir Ahmad	01/12/2009	Amara Abdi
Inventor search for double patenting	01/12/2009	Amara Abdi

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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